

AUTOMOTIVE GRADE

AUIRFS3206 AUIRFSL3206

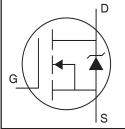
Features

- Advanced Process Technology
- Ultra Low On-Resistance
- Enhanced dV/dT and dI/dT capability
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

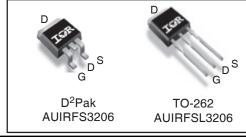
Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

HEXFET® Power MOSFET



$V_{(BR)DSS}$	60V
R _{DS(on)} typ.	$2.4 m\Omega$
max.	3.0 m Ω
I _{D (Silicon Limited)}	210A ①
I _{D (Package Limited)}	120A



G	D	S
Gate	Drain	Source

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	210①	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	150 ①	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	120] ^
I _{DM}	Pulsed Drain Current ②	840	
P _D @T _C = 25°C	Maximum Power Dissipation	300	W
	Linear Derating Factor	2.0	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS (Thermally limited)}	Single Pulse Avalanche Energy ③	170	mJ
I _{AR}	Avalanche Current ②	See Fig. 14, 15, 22a, 22b,	Α
E _{AR}	Repetitive Avalanche Energy ②		mJ
dv/dt	Peak Diode Recovery ®	5.0	V/ns
T_J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

	Parameter	Typ.	Max.	Units					
$R_{\theta JC}$	Junction-to-Case ®		0.50	°C/W					
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount), D2Pak ®		40						

HEXFET® is a registered trademark of International Rectifier.

^{*}Qualification standards can be found at http://www.irf.com/

Static Characteristics @ T_J = 25°C (unless otherwise stated)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.07		V/°C	Reference to 25°C, I _D = 5mA ^②
R _{DS(on)}	Static Drain-to-Source On-Resistance		2.4	3.0	mΩ	$V_{GS} = 10V, I_D = 75A$ ⑤
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 150\mu A$
gfs	Forward Transconductance	210			S	$V_{DS} = 50V, I_{D} = 75A$
R_{G}	Internal Gate Resistance		0.7		Ω	
I _{DSS}	Drain-to-Source Leakage Current			20		$V_{DS} = 60V, V_{GS} = 0V$
				250	μΑ	$V_{DS} = 48V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	n 1	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V

Dynamic Characteristics @ T_J = 25°C (unless otherwise stated)

	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge		120	170		I _D = 75A
Q_{gs}	Gate-to-Source Charge		29		nC	$V_{DS} = 30V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		35		nc	V _{GS} = 10V ⑤
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		85			$I_D = 75A, V_{DS} = 0V, V_{GS} = 10V$
t _{d(on)}	Turn-On Delay Time		19			$V_{DD} = 30V$
t _r	Rise Time		82			$I_D = 75A$
t _{d(off)}	Turn-Off Delay Time		55		ns	$R_G = 2.7\Omega$
t _f	Fall Time		83			V _{GS} = 10V ⑤
C _{iss}	Input Capacitance		6540			$V_{GS} = 0V$
C _{oss}	Output Capacitance		720			$V_{DS} = 50V$
C _{rss}	Reverse Transfer Capacitance		360		pF	f = 1.0MHz, See Fig.5
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related)		1040			$V_{GS} = 0V$, $V_{DS} = 0V$ to 48V \odot , See Fig.11
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related)®		1230			V _{GS} = 0V, V _{DS} = 0V to 48V ⑥

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			210①		MOSFET symbol
	(Body Diode)			2100	Α	showing the
I _{SM}	Pulsed Source Current			840	^	integral reverse
	(Body Diode) ②			040		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25$ °C, $I_S = 75A$, $V_{GS} = 0V$ $\$$
t _{rr}	Reverse Recovery Time		33	50	no	$T_J = 25$ °C $V_R = 51V$,
			37	56	ns	$T_J = 125^{\circ}C$ $I_F = 75A$
Q_{rr}	Reverse Recovery Charge		41	62	~C	$T_J = 25^{\circ}C$ di/dt = 100A/ μ s \odot
			53	80	nC	$T_J = 125^{\circ}C$
I _{RRM}	Reverse Recovery Current		2.1		Α	$T_J = 25^{\circ}C$
t _{on}	Forward Turn-On Time	Intrins	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

Notes:

- ① Calculated continuous current based on maximum allowable junction ④ $I_{SD} \le 75A$, $di/dt \le 360A/\mu s$, $V_{DD} \le V_{(BR)DSS}$, $T_J \le 175^{\circ}C$. temperature. Bond wire current limit is 120A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- $R_G = 25\Omega$, $I_{AS} = 120A$, $V_{GS} = 10V$. Part not recommended for use above this value.
- ⑤ Pulse width $\leq 400\mu s$; duty cycle $\leq 2\%$.
- © Coss eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% $V_{\text{DSS}}.$
- $\ensuremath{ \bigcirc }$ Coss eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- ® When mounted on 1" square PCB (FR-4 or G-10 Material). For recom mended footprint and soldering techniques refer to application note #AN-994.

Qualification Information[†]

		Automotive			
		(per AEC-Q101) ^{††}			
Qualification Level		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Moisture Sensitivity Level		3L-D2 PAK	MSL1		
Woisture Serisi	itivity Level	3L-TO-262	N/A		
	Machine Model	Class M4(+/- 800V) 1 †††			
	Macrime Model	(per AEC-Q101-002)			
ECD	Lluman Dady Madal	Class H2(+/- 4000V) ***			
ESD	ESD Human Body Model		(per AEC-Q101-001)		
Charged Device Model		Class C5(+/- 2000V) ^{†††}			
		(per AEC-Q101-005)			
RoHS Complia	nt		Yes		

[†] Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

^{††} Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

^{†††} Highest passing voltage

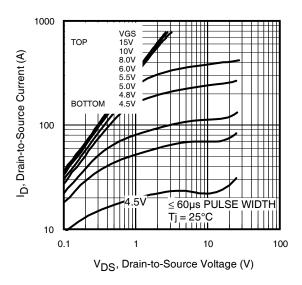


Fig 1. Typical Output Characteristics

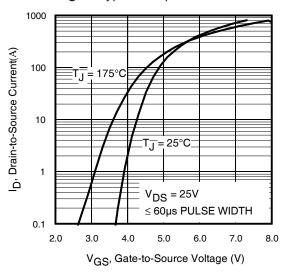


Fig 3. Typical Transfer Characteristics

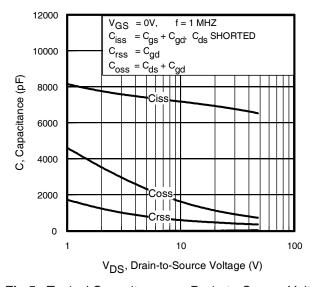


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage 4

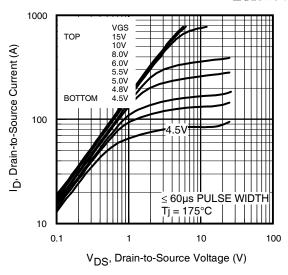


Fig 2. Typical Output Characteristics

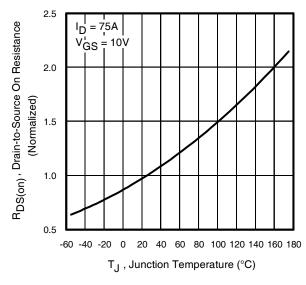


Fig 4. Normalized On-Resistance vs. Temperature

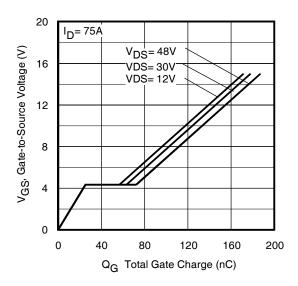


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage www.irf.com

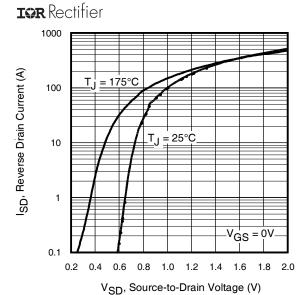


Fig 7. Typical Source-Drain Diode Forward Voltage

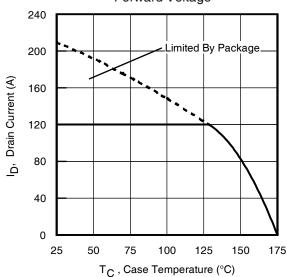


Fig 9. Maximum Drain Current vs. Case Temperature

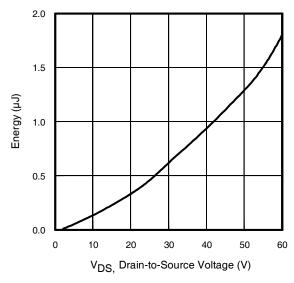


Fig 11. Typical C_{OSS} Stored Energy www.irf.com

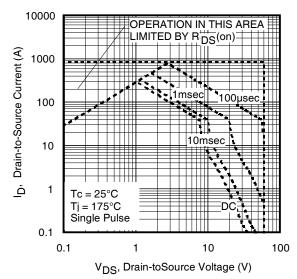


Fig 8. Maximum Safe Operating Area

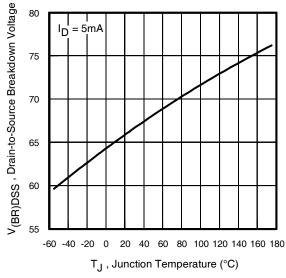


Fig 10. Drain-to-Source Breakdown Voltage

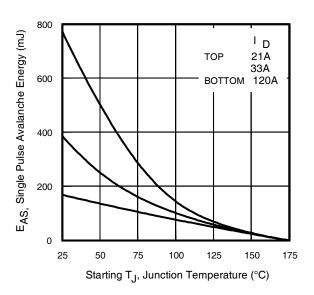


Fig 12. Maximum Avalanche Energy Vs. DrainCurrent

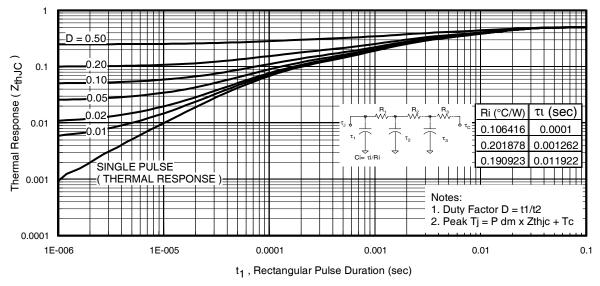


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

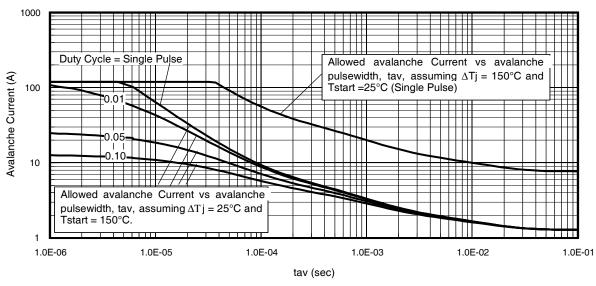


Fig 14. Typical Avalanche Current vs. Pulsewidth

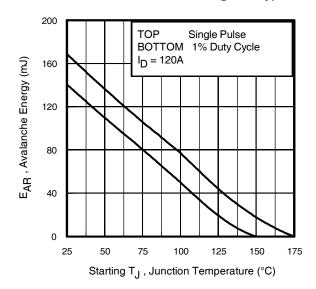


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{imax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 22a, 22b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).

t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{th,JC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D\;(ave)} &= 1/2\;(\;1.3 \cdot BV \cdot I_{av}) = \triangle T/\;Z_{thJC} \\ I_{av} &= 2\triangle T/\;[1.3 \cdot BV \cdot Z_{th}] \\ E_{AS\;(AR)} &= P_{D\;(ave)} \cdot t_{av} \end{split}$$

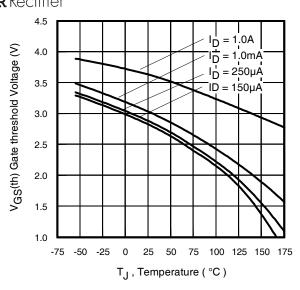


Fig 16. Threshold Voltage Vs. Temperature

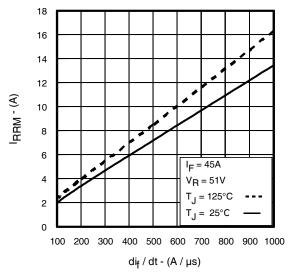


Fig. 18 - Typical Recovery Current vs. dif/dt

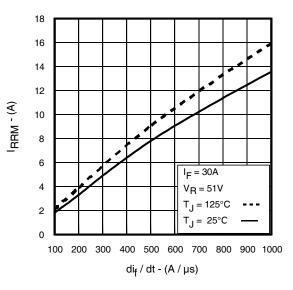


Fig. 17 - Typical Recovery Current vs. di_f/dt

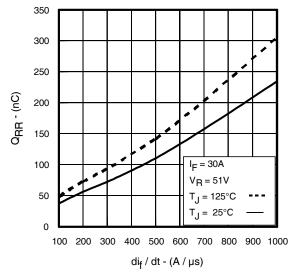


Fig. 19 - Typical Stored Charge vs. di_f/dt

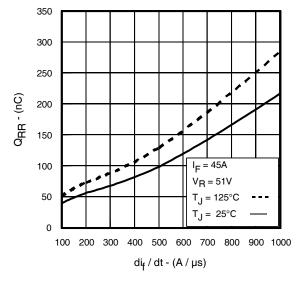


Fig. 20 - Typical Stored Charge vs. dif/dt

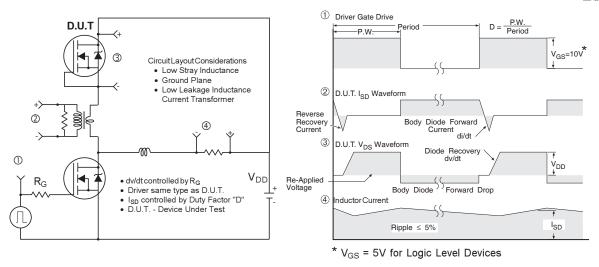


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

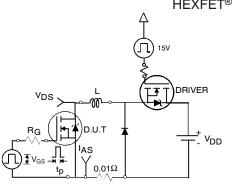


Fig 22a. Unclamped Inductive Test Circuit

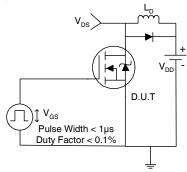


Fig 23a. Switching Time Test Circuit

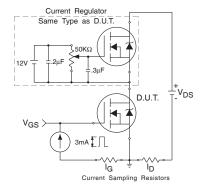


Fig 24a. Gate Charge Test Circuit

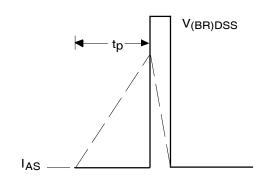


Fig 22b. Unclamped Inductive Waveforms

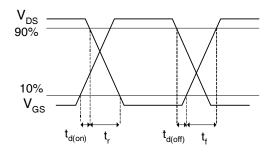


Fig 23b. Switching Time Waveforms

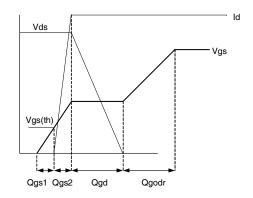
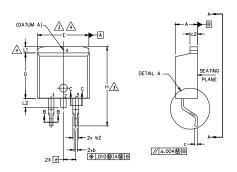
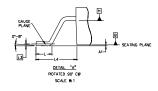


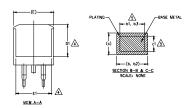
Fig 24b. Gate Charge Waveform

D²Pak Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S Y M			N O		
B 0	MILLIM	ETERS	INC	HES	ITI
L	MIN.	MAX.	MIN.	MAX.	E S
Α	4,06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
b	0.51	0.99	.020	.039	
ь1	0,51	0,89	.020	.035	5
b2	1,14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6,86	-	.270		4
Ε	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
e	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	-	1.65	-	.066	4
L2	1.27	1.78	-	.070	
L3	0.25	BSC	.010	.010 BSC	
L4	4.78	5.28	.188	.208	

LEAD ASSIGNMENTS

HEXFET

1.- GATE 2. 4.- DRAIN 3.- SOURCE

IGBTs, CoPACK

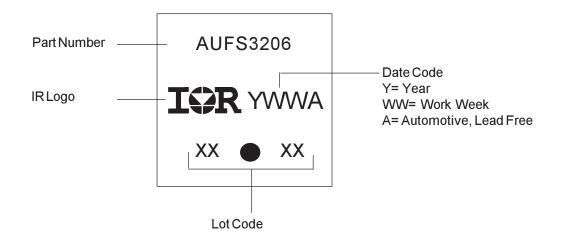
1.- GATE
2, 4.- COLLECTOR
3.- EMITTER

DIODES

1.- ANODE *
2, 4.- CATHODE
3.- ANODE

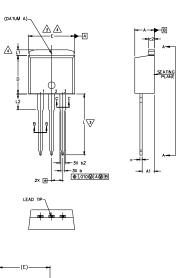
* PART DEPENDENT.

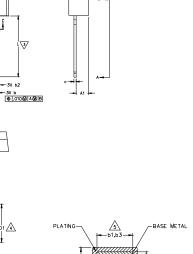
D²Pak Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

TO-262 Package Outline (Dimensions are shown in millimeters (inches))





SECTION B-B & C-C SCALE: NONE

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE, THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

S Y M	DIMENSIONS				
	MILLIM	ILLIMETERS INCHES			
B O L	MIN.	MAX.	MIN.	MAX.	O T E S
Α	4,06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
Ь	0.51	0.99	.020	.039	
b1	0.51	0.89	.020	.035	5
ь2	1,14	1,78	.045	.070	
b3	1,14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1,14	1,65	.045	.065	
D	8,38	9.65	.330	.380	3
D1	6.86	-	.270	-	4
E	9,65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
e	2.54	BSC	.100	BSC	
L	13.46	14,10	.530	.555	
L1	-	1.65	_	.065	4
L2	3.56	3,71	.140	.146	

LEAD ASSIGNMENTS

HEXFET

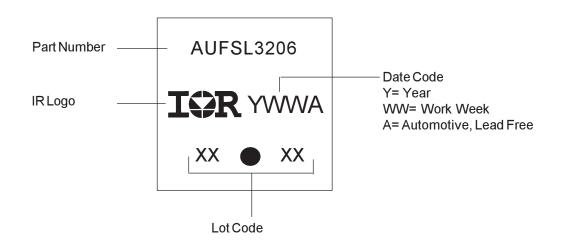
- 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

IGBTs, CoPACK

- 1.- GATE
- 2.- COLLECTOR 3.- EMITTER
- 4.- COLLECTOR

TO-262 Part Marking Information

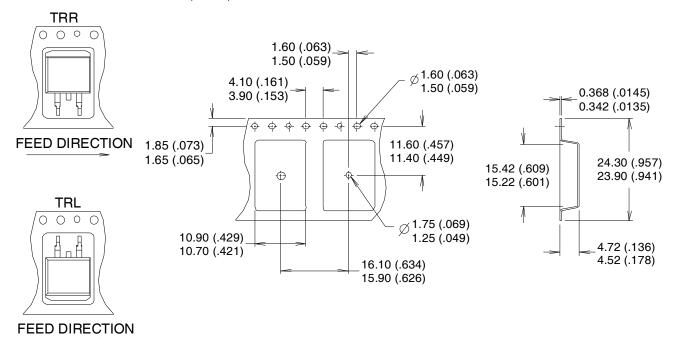
SECTION A-A

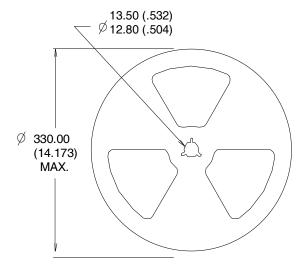


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

D²Pak (TO-263AB) Tape & Reel Information

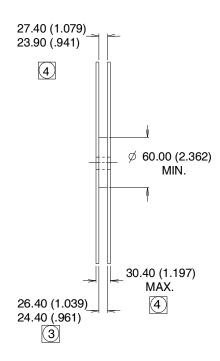
Dimensions are shown in millimeters (inches)







- 1. COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3 DIMENSION MEASURED @ HUB.
- 4 INCLUDES FLANGE DISTORTION @ OUTER EDGE.



Ordering Information

Base part	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRFSL3206	TO-262	Tube	50	AUIRFSL3206
AUIRFS3206	D2Pak	Tube	50	AUIRFS3206
		Tape and Reel Left	800	AUIRFS3206TRL
		Tape and Reel Right	800	AUIRFS3206TRR

IMPORTANT NOTICE

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WORLDHEADQUARTERS:

101 N. Sepulveda Blvd., El Segundo, California 90245

Tel: (310) 252-7105